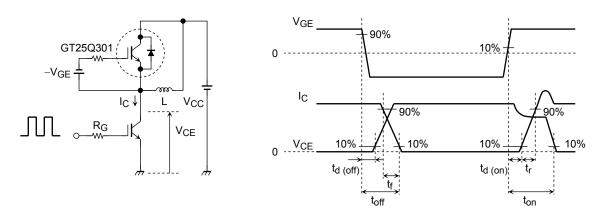


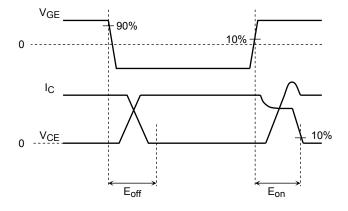
Electrical Characteristics (Ta = 25°C)

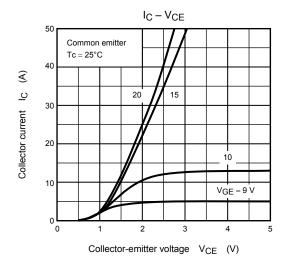
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GES}	$V_{GE} = \pm 20 \text{ V}, V_{CE} = 0$	_	_	±500	nA
Collector cut-off current		I _{CES}	V _{CE} = 1200 V, V _{GE} = 0	_	_	1.0	mA
Gate-emitter cut-off voltage		V _{GE} (OFF)	$I_C = 2.5$ mA, $V_{CE} = 5$ V	4.0	_	7.0	V
Collector-emitter saturation voltage		V _{CE} (sat)	I _C = 25 A, V _{GE} = 15 V	_	2.1	2.7	V
Input capacitance		C _{ies}	V _{CE} = 50 V, V _{GE} = 0, f = 1 MHz	_	1360	_	pF
Switching time	Rise time	t _r	Inductive Load	_	0.10	_	- μ s
	Turn-on time	t _{on}	V _{CC} = 600 V, I _C = 25 A	_	0.30	_	
	Fall time	t _f	$V_{GG} = \pm 15 \text{ V}, R_G = 43 \Omega$	_	0.16	0.32	
	Turn-off time	t _{off}	(Note1)	_	0.68	_	
Thermal resistance		R _{th (j-c)}	_	_	_	0.625	°C/W

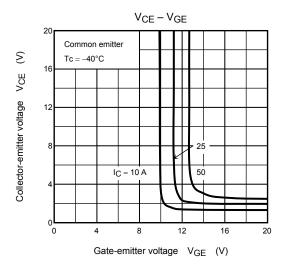
Note1: Switching time measurement circuit and input/output waveforms

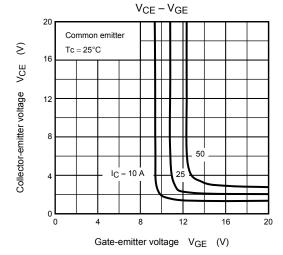


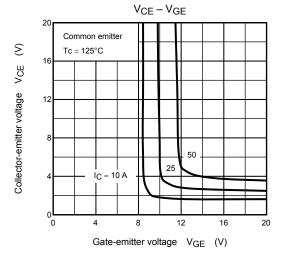
Note2: Switching loss measurement waveforms

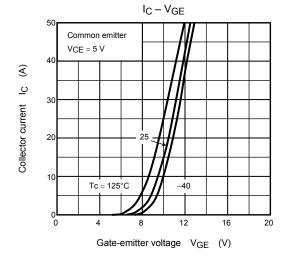


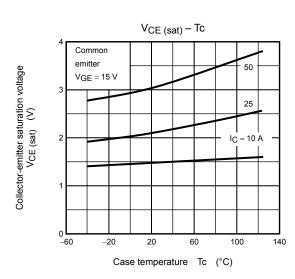




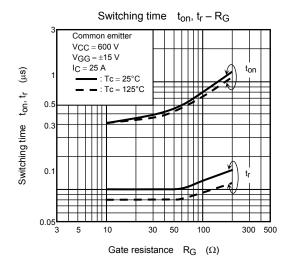


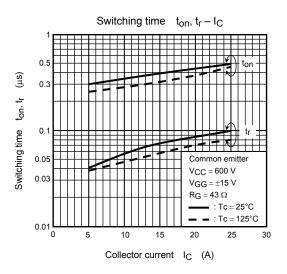


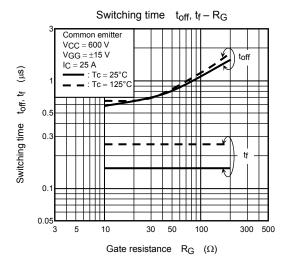


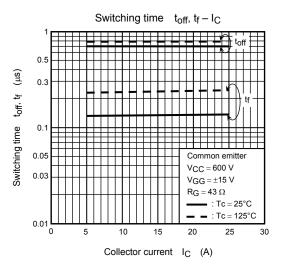


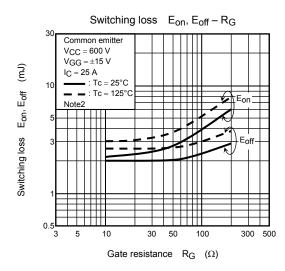
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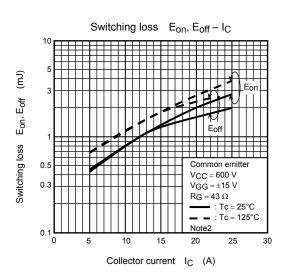


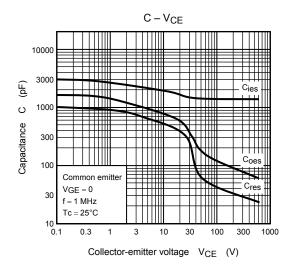


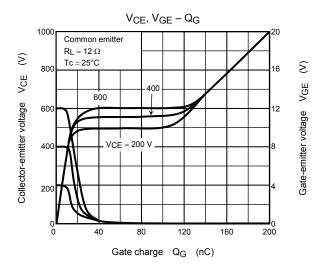


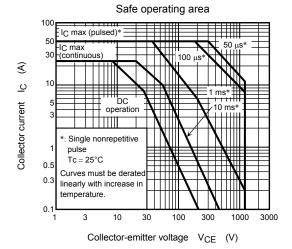


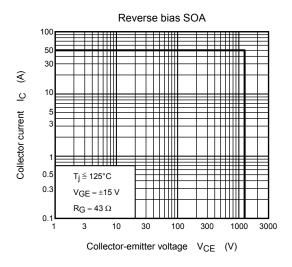


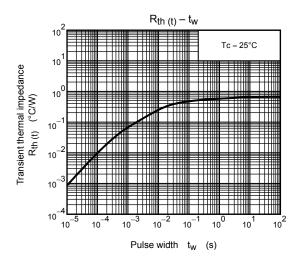












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